NOTES:

- 1. SUBSTRATE FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL TO SURFACE S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE):

S1: 1064 HR Coating R (ABS) > 99.80% @ 1064nm @ 45° AOI R (AVG) > 99.5% @ 1046 - 1074nm @ 45° AOI

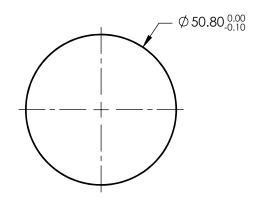
DAMAGE THRESHOLD, PULSED: 20 J/cm², 20ns, 20Hz @ 1064nm CW: 1MW/cm² @ 1064nm

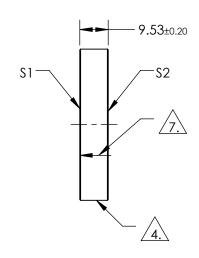
S2: NONE

4. FINE GRIND SURFACE

- POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES

APPLY ARROW ON EDGE WITH LASER ETCH, PENCIL, OR PERMANENT INK POINTING TOWARDS SURFACE S1





FOR INFORMATION ONLY:
DO NOT MANUFACTURE
PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	S1	S2				
SHAPE	PLANO	PLANO			Edmund Option	C®
SURFACE QUALITY	10-5	COMMERCIAL POLISH				J3"
SURFACE FLATNESS	0.10 WAVE	N/A			Ø50.8mm x 9.53mm,1064nm, NdYAG M	NIRR∩R
MIN CLEAR APERTURE	Ø40.64	N/A	THIRD ANGLE PROJECTION	TITLE	45° AOI	IIIKKOK
MIN COATING APERTURE	Ø45.72	N/A]		10 7101	CHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	38900	SHEET 1 OF 1